TOSHIBA THS126

TOSHIBA HALL SENSOR GaAs ION IMPLANTED PLANAR TYPE

THS126

HIGH STABILITY MOTOR CONTROL.

DIGITAL TACHOMETER.

CRANK SHAFT POSITION SENSOR.

Excellent Temperature Characteristics.

Wide Operating Temperature Range. (; −55~125°C)

Excellent Output Voltage Linearity.

High Internal Resistance. : $R_d = 1000\Omega$ (Min.)

Low Residual Voltage Ratio. : $V_{\mbox{HO}}/V_{\mbox{H}} = \pm 5\%$ (Max.)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Control Voltage	$v_{\rm C}$	12	V
Power Dissipation	$P_{\mathbf{D}}$	150	mW
Operating Temperature Range	$T_{ m opr}$	-55~125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	°C

Unit in mm C 0.7 0.6 MAX 1(+) -3(-)(INPUT) 2(+)-4(-)(OUTPUT)JEDEC **EIAJ** TOSHIBA 10-4B1A

Weight: 0.06g

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERI	STIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Internal Resistance (Input)		R_d	I _C =1mA	1000	1250	1500	Ω
Residual Voltage Ratio V		$v_{\mathrm{HO}}/v_{\mathrm{H}}$	$V_C = 5V, B = 0/B = 0.1T$	_	_	±5	%
Hall Voltage	(Note 1)	$V_{ m H}$	$V_{C} = 5V, B = 0.1T$	130	150	170	mV
Temperature Coefficient (Note 2)		$ m v_{HT}$	I _C =5mA, B=0.1T T1=25°C, T2=125°C	_	_	-0.06	%/°C
Linearity	(Note 3)	⊿K _H	$V_C = 5V$, $B1 = 0.05T$, $B2 = 0.1T$	_	_	2	%
Specific Sensitivity	(Note 4)	K*	$V_{C} = 5V, B = 0.1T$	_	30		$ imes 10^{-2} / \mathrm{T}$
Internal Resistance	(Output)	$R_{ m OUT}$	I _C =1mA	1800	2375	3000	Ω

Note 1 : $V_H = V_{HM} - V_{HO} (V_{HM})$ is meter indication)

$$\begin{array}{l} {\rm Note} \ \ 2: V_{HT} = \ \frac{1}{V_{H \ (T1)}} \cdot \frac{V_{H \ (T2)} - V_{H \ (T1)}}{T^2 - T1} \times 100 \ (\% \ / \ ^{\circ}C) \\ {\rm Note} \ \ 3: \Delta K_{H} = \ \frac{K_{H \ (B2)} - K_{H \ (B1)}}{1 \ / \ 2 \left\{ K_{H \ (B1)} + K_{H \ (B2)} \right\}} \times 100 \ (\%), \ K_{H} = \ \frac{V_{H}}{I_{C} \cdot B} \ K_{H}: Product \ Sensitivity \end{array}$$

Note 3:
$$\Delta K_{H} = \frac{K_{H}(B2) - K_{H}(B1)}{1/2\{K_{H}(B1) + K_{H}(B2)\}} \times 100 (\%), K_{H} = \frac{V_{H}}{I_{C} \cdot B} K_{H}$$
: Product Sensitivity

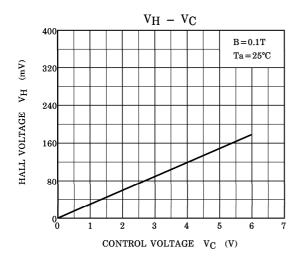
Note 4: $K^*=V_H/(R_d\times I_C\times B)=K_H/R_d$

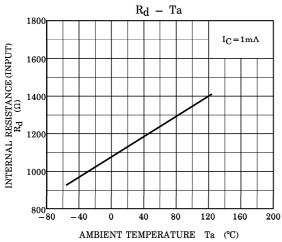
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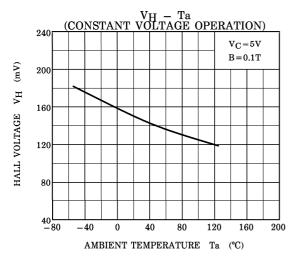
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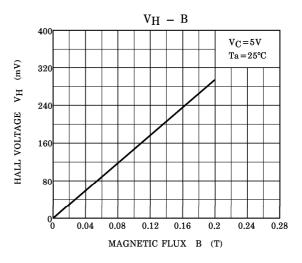
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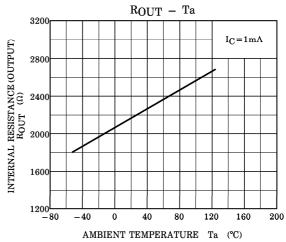
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